# 74HC4351-Q100; 74HCT4351-Q100 8-channel analog multiplexer/demultiplexer with latch

Rev. 1 — 2 November 2023 Product data sheet

# 1. General description

The 74HC4351-Q100; 74HCT4351-Q100 is a single-pole octal-throw analog switch (SP8T) suitable for use in analog or digital 8:1 multiplexer/demultiplexer applications. The switch features three digital select inputs (S0 to S2), eight independent inputs/outputs (Yn), a common input/output (Z) and two digital enable inputs (E1 and E2). With E1 LOW and E2 HIGH, one of the eight switches is selected (low impedance ON-state) by S0 to S2. The data at the select inputs may be latched by using the latch enable input ( $\overline{LE}$ ). When  $\overline{LE}$  is HIGH the latch is transparent. When  $\overline{E1}$  is HIGH or E2 is LOW all 8 analog switches are turned off. Inputs include clamp diodes. This enables the use of current limiting resistors to interface inputs to voltages in excess of V<sub>CC</sub>.

This product has been qualified to the Automotive Electronics Council (AEC) standard Q100 (Grade 1) and is suitable for use in automotive applications.

# 2. Features and benefits

- Automotive product qualification in accordance with AEC-Q100 (Grade 1) Specified from -40 °C to +85 °C and from -40 °C to +125 °C
- Wide analog input voltage range from -5 V to +5 V
- Complies with JEDEC standard no. 7A
- Low ON resistance:
  - 80 Ω (typical) at V<sub>CC</sub> V<sub>EE</sub> = 4.5 V
  - 70  $\Omega$  (typical) at V<sub>CC</sub> V<sub>EE</sub> = 6.0 V
  - 60  $\Omega$  (typical) at V<sub>CC</sub> - V<sub>EE</sub> = 9.0 V
- Logic level translation: to enable 5 V logic to communicate with ±5 V analog signals
- Typical 'break before make' built-in
- Address latches provided
- ESD protection:
  - HBM JESD22-A114F exceeds 2000 V
  - MM JESD22-A115-A exceeds 200 V
  - CDM JESD22-C101E exceeds 1000 V

# 3. Applications

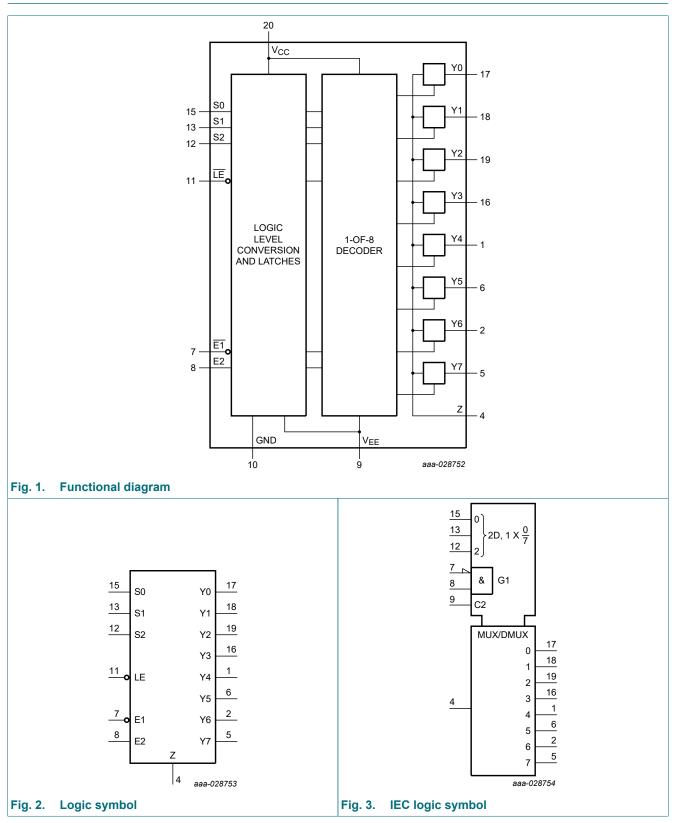
- Analog multiplexing and demultiplexing
- Digital multiplexing and demultiplexing
- Signal gating

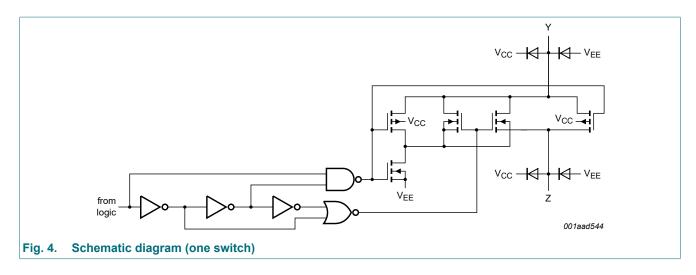
# 4. Ordering information

#### **Table 1. Ordering information**

Type number	Package	skage									
	Temperature range	Name	Description	Version							
74HC4351D-Q100 74HCT4351D-Q100	-40 °C to +125 °C	SO20	plastic small outline package; 20 leads; body width 7.5 mm	<u>SOT163-1</u>							

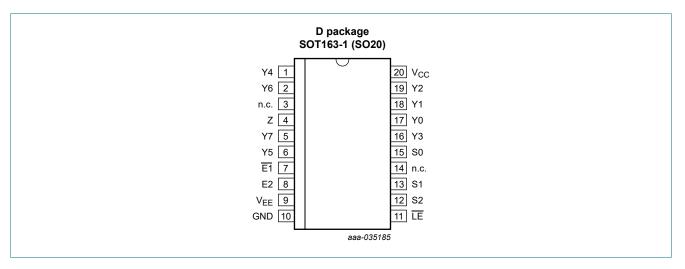
# 5. Functional diagram





# 6. Pinning information

# 6.1. Pinning



# 6.2. Pin description

Table 2. Pin description		
Symbol	Pin	Description
E1	7	enable input (active LOW)
E2	8	enable input (active HIGH)
LE	11	latch enable input (active LOW)
S0, S1, S2	15, 13, 12	select inputs
Y0, Y1, Y2, Y3, Y4, Y5, Y6, Y7	17, 18, 19, 16, 1, 6, 2, 5	independent input or output
Z	4	common output or input
V <sub>EE</sub>	9	supply voltage
GND	10	ground (0 V)
V <sub>cc</sub>	20	supply voltage
n.c.	3, 14	not connected

# 7. Functional description

#### Table 3. Function table

H = HIGH voltage level; L = LOW voltage level; X = don't care;  $\downarrow = HIGH$ -to-LOW  $\overline{LE}$  transition.

Input						Channel ON
E1	E2	LE	S2	S1	S0	
Н	Х	Х	X	Х	X	none
Х	L	Х	Х	Х	X	none
L	Н	Н	L	L	L	Y0
L	Н	Н	L	L	Н	Y1
L	Н	Н	L	Н	L	Y2
L	Н	Н	L	Н	Н	Y3
L	Н	Н	н	L	L	Y4
L	Н	Н	Н	L	Н	Y5
L	Н	Н	н	Н	L	Y6
L	Н	Н	н	Н	Н	Y7
L	Н	L	Х	Х	X	last selected channel "ON"
Х	Х	Ļ	Х	Х	Х	select channels latched

# 8. Limiting values

## Table 4. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134). Voltages are referenced to V<sub>SS</sub> = 0 V (ground).

Symbol	Parameter	Conditions	Min	Мах	Unit
V <sub>CC</sub>	supply voltage	[1]	-0.5	+11.0	V
I <sub>IK</sub>	input clamping current	$V_{I}$ < -0.5 V or $V_{I}$ > $V_{CC}$ + 0.5 V	-	±20	mA
I <sub>SK</sub>	switch clamping current	$V_{\rm SW}$ < -0.5 V or $V_{\rm SW}$ > $V_{\rm CC}$ + 0.5 V	-	±20	mA
I <sub>SW</sub>	switch current	$-0.5 V < V_{SW} < V_{CC} + 0.5 V$	-	±25	mA
I <sub>EE</sub>	supply current		-	±20	mA
I <sub>CC</sub>	supply current		-	50	mA
I <sub>GND</sub>	ground current		-50	-	mA
T <sub>stg</sub>	storage temperature		-65	+150	°C
P <sub>tot</sub>	total power dissipation	$T_{amb} = -40 \text{ °C to } +125 \text{ °C}$ [2]	-	500	mW
Р	power dissipation	per switch	-	100	mW

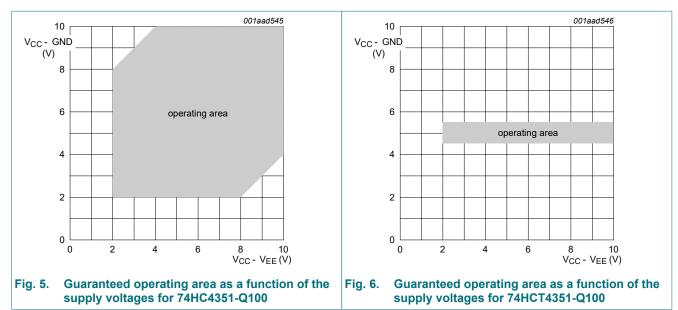
[1] To avoid drawing  $V_{CC}$  current out of terminal Z, when switch current flows into terminals Yn, the voltage drop across the bidirectional switch must not exceed 0.4 V. If the switch current flows into terminal Z, no  $V_{CC}$  current will flow out of terminals Yn. In this case there is no limit for the voltage drop across the switch, but the voltages at Yn and Z may not exceed  $V_{CC}$  or  $V_{EE}$ .

[2] For SOT163-1 (SO20) package: P<sub>tot</sub> derates linearly with 12.3 mW/K above 109 °C.

# 9. Recommended operating conditions

## Table 5. Recommended operating conditions

Symbol	Parameter	Conditions	74H	IC4351-C	100	74H	CT4351-0	Q100	Unit
			Min	Тур	Max	Min	Тур	Max	-
V <sub>CC</sub>	supply voltage	see <u>Fig. 5</u> and <u>Fig. 6</u>							
		V <sub>CC</sub> - GND	2.0	5.0	10.0	4.5	5.0	5.5	V
		V <sub>CC</sub> - V <sub>EE</sub>	2.0	5.0	10.0	2.0	5.0	10.0	V
VI	input voltage		GND	-	V <sub>CC</sub>	GND	-	V <sub>CC</sub>	V
V <sub>SW</sub>	switch voltage		V <sub>EE</sub>	-	V <sub>CC</sub>	V <sub>EE</sub>	-	V <sub>CC</sub>	V
T <sub>amb</sub>	ambient temperature		-40	+25	+125	-40	+25	+125	°C
Δt/ΔV	input transition rise	V <sub>CC</sub> = 2.0 V	-	-	625	-	-	-	ns/V
	and fall rate	V <sub>CC</sub> = 4.5 V	-	1.67	139	-	1.67	139	ns/V
	Ν	V <sub>CC</sub> = 6.0 V	-	-	83	-	-	-	ns/V
		V <sub>CC</sub> = 10.0 V	-	-	31	-	-	-	ns/V



# **10. Static characteristics**

## Table 6. R<sub>ON</sub> resistance per latch for 74HC4351-Q100 and 74HCT4351-Q100

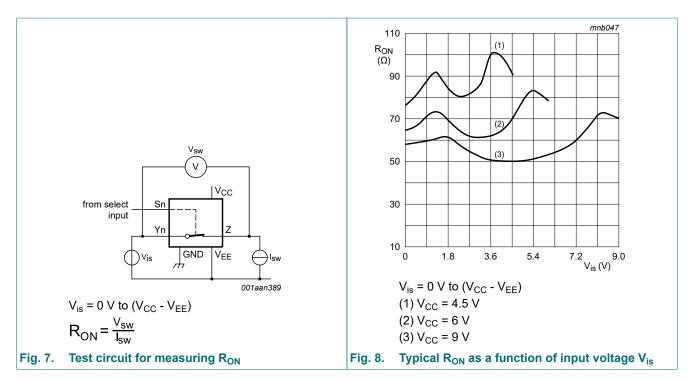
For test circuit, see Fig. 7

For 74HC4351-Q100:  $V_I = V_{IH}$  or  $V_{IL}$ ;  $V_{CC}$  - GND or  $V_{CC}$  -  $V_{EE} = 2.0$  V, 4.5 V, 6.0 V and 9.0 V. For 74HCT4351-Q100:  $V_I = V_{IH}$  or  $V_{IL}$ ;  $V_{CC}$  - GND = 4.5 V and 5.5 V,  $V_{CC}$  -  $V_{EE} = 2.0$  V, 4.5 V, 6.0 V and 9.0 V.

Symbol	Parameter	Conditions			25 °C		-40 °C to	o +85 °C	-40 °C to	o +125 °C	Unit
				Min	Тур	Max	Min	Max	Min	Max	
R <sub>ON(peak)</sub>		$V_{is} = V_{CC}$ to $V_{EE}$	[1]								
	(peak)	V <sub>CC</sub> = 2.0 V; V <sub>EE</sub> = 0 V; I <sub>SW</sub> = 100 µA	[2]	-	-	-	-	-	-	-	Ω
		V <sub>CC</sub> = 4.5 V; V <sub>EE</sub> = 0 V; I <sub>SW</sub> = 1000 μA		-	100	180	-	225	-	270	Ω
		V <sub>CC</sub> = 6.0 V; V <sub>EE</sub> = 0 V; I <sub>SW</sub> = 1000 μA		-	90	160	-	200	-	240	Ω
		V <sub>CC</sub> = 4.5 V; V <sub>EE</sub> = -4.5 V; I <sub>SW</sub> = 1000 μA		-	70	130	-	165	-	195	Ω
R <sub>ON(rail)</sub>	ON resistance	$V_{is} = V_{EE}$	[1]								
	(rail)	$V_{CC}$ = 2.0 V; $V_{EE}$ = 0 V; $I_{SW}$ = 100 µA	[2]	-	150	-	-	-	-	-	Ω
		V <sub>CC</sub> = 4.5 V; V <sub>EE</sub> = 0 V; I <sub>SW</sub> = 1000 μA		-	80	140	-	175	-	210	Ω
		V <sub>CC</sub> = 6.0 V; V <sub>EE</sub> = 0 V; I <sub>SW</sub> = 1000 μA		-	70	120	-	150	-	180	Ω
		V <sub>CC</sub> = 4.5 V; V <sub>EE</sub> = -4.5 V; I <sub>SW</sub> = 1000 μA		-	60	105	-	130	-	160	Ω
		V <sub>is</sub> = V <sub>CC</sub>	[1]								
		V <sub>CC</sub> = 2.0 V; V <sub>EE</sub> = 0 V; I <sub>SW</sub> = 100 μA	[2]	-	150	-	-	-	-	-	Ω
		V <sub>CC</sub> = 4.5 V; V <sub>EE</sub> = 0 V; I <sub>SW</sub> = 1000 μA		-	90	160	-	200	-	240	Ω
		V <sub>CC</sub> = 6.0 V; V <sub>EE</sub> = 0 V; I <sub>SW</sub> = 1000 µA		-	80	140	-	175	-	210	Ω
		V <sub>CC</sub> = 4.5 V; V <sub>EE</sub> = -4.5 V; I <sub>SW</sub> = 1000 µA		-	65	120	-	150	-	180	Ω
ΔR <sub>ON</sub>	ON resistance	$V_{is} = V_{CC}$ to $V_{EE}$	[1]								
	mismatch between	V <sub>CC</sub> = 2.0 V; V <sub>EE</sub> = 0 V	[2]	-	-	-	-	-	-	-	Ω
	channels	V <sub>CC</sub> = 4.5 V; V <sub>EE</sub> = 0 V		-	9	-	-	-	-	-	Ω
		V <sub>CC</sub> = 6.0 V; V <sub>EE</sub> = 0 V		-	8	-	-	-	-	-	Ω
		V <sub>CC</sub> = 4.5 V; V <sub>EE</sub> = -4.5 V		-	6	-	-	-	-	-	Ω

[1]  $V_{is}$  is the input voltage at a Yn or Z terminal, whichever is assigned as an input.

[2] When supply voltages ( $V_{CC} - V_{EE}$ ) near 2.0 V the analog switch ON resistance becomes extremely non-linear. When using a supply of 2 V, it is recommended to use these devices only for transmitting digital signals.



#### **Table 7. Static characteristics**

Voltages are referenced to GND (ground = 0 V);

 $V_{is}$  is the input voltage at pins Yn or Z, whichever is assigned as an input;

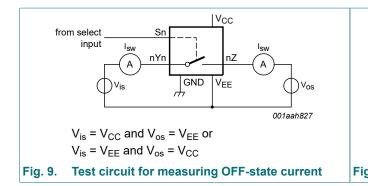
 $V_{os}$  is the output voltage at pins Z or Yn, whichever is assigned as an output.

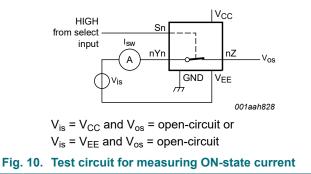
Symbol	Parameter	Conditions		25 °C		-40 °C te	o +85 °C	-40 °C to +125 °C		Unit
			Min	Тур	Max	Min	Мах	Min	Мах	
74HC43	51-Q100			1		1				
VIH	HIGH-level	V <sub>CC</sub> = 2.0 V	1.5	1.2	-	1.5	-	1.5	-	V
	input voltage	V <sub>CC</sub> = 4.5 V	3.15	2.4	-	3.15	-	3.15	-	V
		V <sub>CC</sub> = 6.0 V	4.2	3.2	-	4.2	-	4.2	-	V
		V <sub>CC</sub> = 9.0 V	6.3	4.7	-	6.3	-	6.3	-	V
V <sub>IL</sub>	LOW-level	V <sub>CC</sub> = 2.0 V	-	0.8	0.5	-	0.5	-	0.5	V
	input voltage	V <sub>CC</sub> = 4.5 V	-	2.1	1.35	-	1.35	-	1.35	V
		V <sub>CC</sub> = 6.0 V	-	2.8	1.8	-	1.8	-	1.8	V
		V <sub>CC</sub> = 9.0 V	-	4.3	2.7	-	2.7	-	2.7	V
l <sub>l</sub>	input leakage	$V_{EE}$ = 0 V; $V_{I}$ = $V_{CC}$ or GND								
	current	V <sub>CC</sub> = 6.0 V	-	-	±0.1	-	±1.0	-	±1.0	μA
		V <sub>CC</sub> = 10.0 V	-	-	±0.2	-	±2.0	-	±2.0	μA
I <sub>S(OFF)</sub>	OFF-state leakage current									
		per channel	-	-	±0.1	-	±1.0	-	±1.0	μA
		all channels	-	-	±0.4	-	±4.0	-	±4.0	μA
I <sub>S(ON)</sub>	ON-state leakage current	$\label{eq:V_CC} \begin{array}{l} V_{CC} = 10.0 \; V; \; V_{EE} = 0 \; V; \\ V_{I} = V_{IH} \; \text{or} \; V_{IL}; \\  V_{SW}  = V_{CC} - V_{EE}; \; \text{see} \; \underline{Fig. \; 10} \end{array}$	-	-	±0.4	-	±4.0	-	±4.0	μA

Symbol	Parameter	Conditions		25 °C		-40 °C t	o +85 °C	-40 °C to +125 °C		Unit
			Min	Тур	Мах	Min	Мах	Min	Max	
I <sub>CC</sub>	supply current									
		V <sub>CC</sub> = 6.0 V	-	-	8.0	-	80.0	-	160.0	μA
		V <sub>CC</sub> = 10.0 V	-	-	16.0	-	160.0	-	320.0	μA
CI	input capacitance		-	3.5	-	-	-	-	-	pF
C <sub>sw</sub>	switch	independent pins Yn	-	5	-	-	-	-	-	pF
	capacitance	common pins Z	-	25	-	-	-	-	-	pF
74HCT4	351-Q100		1							
V <sub>IH</sub>	HIGH-level input voltage	V <sub>CC</sub> = 4.5 V to 5.5 V	2.0	1.6	-	2.0	-	2.0	-	V
V <sub>IL</sub>	LOW-level input voltage	V <sub>CC</sub> = 4.5 V to 5.5 V	-	1.2	0.8	-	0.8	-	0.8	V
lı	input leakage current	$V_I = V_{CC}$ or GND; $V_{CC} = 5.5$ V; $V_{EE} = 0$ V	-	-	±0.1	-	±1.0	-	±1.0	μA
I <sub>S(OFF)</sub>	OFF-state leakage current	$V_{CC} = 10.0 V; V_{EE} = 0 V;$ $V_I = V_{IH} \text{ or } V_{IL};$ $ V_{SW}  = V_{CC} - V_{EE}; \text{ see } Fig. 9$								
		per channel	-	-	±0.1	-	±1.0	-	±1.0	μA
		all channels	-	-	±0.4	-	±4.0	-	±4.0	μA
I <sub>S(ON)</sub>	ON-state leakage current	$V_{CC} = 10.0 \text{ V}; V_{EE} = 0 \text{ V};$ $V_I = V_{IH} \text{ or } V_{IL};$ $ V_{SW}  = V_{CC} - V_{EE}; \text{ see } Fig. 10$	-	-	±0.4	-	±4.0	-	±4.0	μA
I <sub>CC</sub>	supply current									
		$V_{CC} = 5.5 \text{ V}; \text{ V}_{EE} = 0 \text{ V}$	-	-	8.0	-	80.0	-	160.0	μA
		$V_{CC}$ = 5.0 V; $V_{EE}$ = -5.0 V	-	-	16.0	-	160.0	-	320.0	μA
ΔI <sub>CC</sub>	additional supply current	per input; other inputs at V <sub>CC</sub> or GND; V <sub>I</sub> = V <sub>CC</sub> - 2.1 V; V <sub>CC</sub> = 4.5 V to 5.5 V; V <sub>EE</sub> = 0 V								
		inputs E1, E2 and Sn	-	50	180	-	225	-	245	μA
		input LE	-	150	540	-	675	-	735	μA
CI	input capacitance		-	3.5	-	-	-	-	-	pF
C <sub>sw</sub>	switch	independent pins Yn	-	5	-	-	-	-	-	pF
	capacitance	common pins Z	-	25	-	_	-	-	-	pF

## 74HC4351-Q100; 74HCT4351-Q100

#### 8-channel analog multiplexer/demultiplexer with latch





# **11. Dynamic characteristics**

#### Table 8. Dynamic characteristics

GND = 0 V;  $t_r = t_f = 6 ns$ ;  $C_L = 50 pF$ ; for test circuit see Fig. 14.  $V_{is}$  is the input voltage at pins Yn or Z, whichever is assigned as an input;  $V_{os}$  is the output voltage at pins Z or Yn, whichever is assigned as an output.

Symbol	Parameter	eter Conditions				-40 °C to	o +85 °C	-40 °C to +125 °C		Unit
			Min	Тур	Max	Min	Max	Min	Max	
74HC43	51-Q100									
t <sub>pd</sub>		$V_{is}$ to $V_{os}$ ; $R_L = \infty \Omega$ ; see <u>Fig. 11</u> [1]								
	delay	V <sub>CC</sub> = 2.0 V; V <sub>EE</sub> = 0 V	-	14	60	-	75	-	90	ns
		V <sub>CC</sub> = 4.5 V; V <sub>EE</sub> = 0 V	-	5	12	-	15	-	18	ns
		V <sub>CC</sub> = 6.0 V; V <sub>EE</sub> = 0 V	-	4	10	-	13	-	15	ns
		V <sub>CC</sub> = 4.5 V; V <sub>EE</sub> = -4.5 V	-	4	8	-	10	-	12	ns
t <sub>on</sub>	turn-ON	E1 to V <sub>os</sub> ; R <sub>L</sub> = 1 kΩ; see Fig. 12								
	time	V <sub>CC</sub> = 2.0 V; V <sub>EE</sub> = 0 V	-	85	300	-	375	-	450	ns
		V <sub>CC</sub> = 4.5 V; V <sub>EE</sub> = 0 V	-	31	60	-	75	-	90	ns
		V <sub>CC</sub> = 6.0 V; V <sub>EE</sub> = 0 V	-	25	51	-	64	-	77	ns
		V <sub>CC</sub> = 4.5 V; V <sub>EE</sub> = -4.5 V	-	28	55	-	69	-	83	ns
		E2 to $V_{os}$ ; $R_L = 1 \text{ k}\Omega$ ; see <u>Fig. 12</u>								
		V <sub>CC</sub> = 2.0 V; V <sub>EE</sub> = 0 V	-	85	300	-	375	-	450	ns
		V <sub>CC</sub> = 4.5 V; V <sub>EE</sub> = 0 V	-	31	60	-	75	-	90	ns
		V <sub>CC</sub> = 6.0 V; V <sub>EE</sub> = 0 V	-	25	51	-	64	-	77	ns
		$V_{CC}$ = 4.5 V; $V_{EE}$ = -4.5 V	-	25	55	-	69	-	83	ns
		$\overline{\text{LE}}$ to V <sub>os</sub> ; R <sub>L</sub> = 1 kΩ; see <u>Fig. 12</u>								
		V <sub>CC</sub> = 2.0 V; V <sub>EE</sub> = 0 V	-	91	300	-	375	-	450	ns
		V <sub>CC</sub> = 4.5 V; V <sub>EE</sub> = 0 V	-	33	60	-	75	-	90	ns
		V <sub>CC</sub> = 6.0 V; V <sub>EE</sub> = 0 V	-	26	51	-	64	-	77	ns
		V <sub>CC</sub> = 4.5 V; V <sub>EE</sub> = -4.5 V	-	27	55	-	69	-	83	ns
		Sn to $V_{os}$ ; $R_L = 1 k\Omega$ ; see Fig. 12								
		V <sub>CC</sub> = 2.0 V; V <sub>EE</sub> = 0 V	-	88	300	-	375	-	450	ns
		V <sub>CC</sub> = 4.5 V; V <sub>EE</sub> = 0 V	-	32	60	-	75	-	90	ns
		V <sub>CC</sub> = 6.0 V; V <sub>EE</sub> = 0 V	-	26	51	-	64	-	77	ns
		V <sub>CC</sub> = 4.5 V; V <sub>EE</sub> = -4.5 V	-	25	50	-	63	-	75	ns

# 74HC4351-Q100; 74HCT4351-Q100

## 8-channel analog multiplexer/demultiplexer with latch

Symbol	Parameter	Conditions		25 °C		-40 °C to	o +85 °C	-40 °C to +125 °C		Unit
			Min	Тур	Max	Min	Max	Min	Max	
t <sub>off</sub>	turn-OFF	$\overline{E1}$ to V <sub>os</sub> ; R <sub>L</sub> = 1 kΩ; see <u>Fig. 12</u>								
	time	V <sub>CC</sub> = 2.0 V; V <sub>EE</sub> = 0 V	-	69	250	-	315	-	375	ns
		V <sub>CC</sub> = 4.5 V; V <sub>EE</sub> = 0 V	-	25	50	-	63	-	75	ns
		V <sub>CC</sub> = 6.0 V; V <sub>EE</sub> = 0 V	-	20	43	-	54	-	64	ns
		V <sub>CC</sub> = 4.5 V; V <sub>EE</sub> = -4.5 V	-	20	40	-	50	-	60	ns
		E2 to $V_{os}$ ; R <sub>L</sub> = 1 k $\Omega$ ; see <u>Fig. 12</u>								
		V <sub>CC</sub> = 2.0 V; V <sub>EE</sub> = 0 V	-	72	250	-	315	-	375	ns
		V <sub>CC</sub> = 4.5 V; V <sub>EE</sub> = 0 V	-	26	50	-	63	-	75	ns
		V <sub>CC</sub> = 6.0 V; V <sub>EE</sub> = 0 V	-	21	43	-	54	-	64	ns
		V <sub>CC</sub> = 4.5 V; V <sub>EE</sub> = -4.5 V	-	19	40	-	50	-	60	ns
		LE to V <sub>os</sub> ; R <sub>L</sub> = 1 kΩ; see Fig. 12								
		V <sub>CC</sub> = 2.0 V; V <sub>EE</sub> = 0 V	-	83	275	-	345	-	415	ns
		V <sub>CC</sub> = 4.5 V; V <sub>EE</sub> = 0 V	-	30	55	-	69	-	83	ns
		V <sub>CC</sub> = 6.0 V; V <sub>EE</sub> = 0 V	-	24	47	-	59	-	71	ns
		V <sub>CC</sub> = 4.5 V; V <sub>EE</sub> = -4.5 V	-	26	45	-	56	-	68	ns
		Sn to $V_{os}$ ; $R_L$ = 1 k $\Omega$ ; see <u>Fig. 12</u>								-
		V <sub>CC</sub> = 2.0 V; V <sub>EE</sub> = 0 V	-	80	275	-	345	-	415	ns
		V <sub>CC</sub> = 4.5 V; V <sub>EE</sub> = 0 V	-	29	55	-	69	-	83	ns
		V <sub>CC</sub> = 6.0 V; V <sub>EE</sub> = 0 V	-	23	47	-	59	-	71	ns
		V <sub>CC</sub> = 4.5 V; V <sub>EE</sub> = -4.5 V	-	24	48	-	60	-	72	ns
t <sub>su</sub>	set-up time	Sn to $\overline{\text{LE}}$ ; $R_{\text{L}}$ = 1 k $\Omega$ ; see <u>Fig. 13</u>								
		V <sub>CC</sub> = 2.0 V; V <sub>EE</sub> = 0 V	60	17	-	-	75	-	90	ns
		V <sub>CC</sub> = 4.5 V; V <sub>EE</sub> = 0 V	12	6	-	-	15	-	18	ns
		V <sub>CC</sub> = 6.0 V; V <sub>EE</sub> = 0 V	10	5	-	-	13	-	15	ns
		V <sub>CC</sub> = 4.5 V; V <sub>EE</sub> = -4.5 V	18	9	-	-	23	-	27	ns
t <sub>hold</sub>	hold time	Sn to $\overline{\text{LE}}$ ; $R_{\text{L}} = 1 \text{ k}\Omega$ ; see Fig. 13								
		V <sub>CC</sub> = 2.0 V; V <sub>EE</sub> = 0 V	5	-8	-	-	5	-	5	ns
		V <sub>CC</sub> = 4.5 V; V <sub>EE</sub> = 0 V	5	-3	-	-	5	-	5	ns
		V <sub>CC</sub> = 6.0 V; V <sub>EE</sub> = 0 V	5	-2	-	-	5	-	5	ns
		V <sub>CC</sub> = 4.5 V; V <sub>EE</sub> = -4.5 V	5	-4	-	-	5	-	5	ns
t <sub>WH(min)</sub>	minimum	LE; R <sub>L</sub> = 1 kΩ; see <u>Fig. 13</u>								
	pulse width	V <sub>CC</sub> = 2.0 V; V <sub>EE</sub> = 0 V	100	11	-	-	125	-	150	ns
	HIGH	V <sub>CC</sub> = 4.5 V; V <sub>EE</sub> = 0 V	20	1	-	-	25	-	30	ns
		V <sub>CC</sub> = 6.0 V; V <sub>EE</sub> = 0 V	17	3	-	-	21	-	26	ns
		V <sub>CC</sub> = 4.5 V; V <sub>EE</sub> = -4.5 V	25	7	-	-	31	-	38	ns
C <sub>pd</sub>	power dissipation capacitance	per switch; $V_1 = GND$ to $V_{CC}$ [2]	-	25	-	-	-	-	-	pF
C <sub>sw</sub>	switch	maximum								
	capacitance	independent (Yn)	-	5	-	-	-	-	-	pF
		common (Z)	-	25	-	-	-	-	-	pF

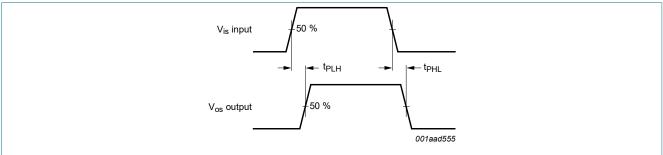
Symbol	Parameter	Conditions		25 °C		-40 °C t	o +85 °C	-40 °C to +125 °C		Unit
			Min	Тур	Max	Min	Max	Min	Max	1
74HCT4	351-Q100								-	
t <sub>pd</sub>	propagation	$V_{is}$ to $V_{os}$ ; $R_L = \infty \Omega$ ; see <u>Fig. 11</u> [1]								
	delay	V <sub>CC</sub> = 4.5 V; V <sub>EE</sub> = 0 V	-	6	12	-	15	-	18	ns
		V <sub>CC</sub> = 4.5 V; V <sub>EE</sub> = -4.5 V	-	4	8	-	10	-	12	ns
t <sub>on</sub>	turn-ON	$\overline{E1}$ to V <sub>os</sub> ; R <sub>L</sub> = 1 kΩ; see <u>Fig. 12</u>								
	time	V <sub>CC</sub> = 4.5 V; V <sub>EE</sub> = 0 V	-	40	75	-	94	-	113	ns
		V <sub>CC</sub> = 4.5 V; V <sub>EE</sub> = -4.5 V	-	31	60	-	75	-	90	ns
		E2 to $V_{os}$ ; $R_L$ = 1 k $\Omega$ ; see <u>Fig. 12</u>								
		V <sub>CC</sub> = 4.5 V; V <sub>EE</sub> = 0 V	-	35	70	-	88	-	105	ns
		V <sub>CC</sub> = 4.5 V; V <sub>EE</sub> = -4.5 V	-	26	50	-	63	-	75	ns
		LE to $V_{os}$ ; $R_L = 1 \text{ k}\Omega$ ; see Fig. 12								
		V <sub>CC</sub> = 4.5 V; V <sub>EE</sub> = 0 V	-	42	75	-	94	-	113	ns
		V <sub>CC</sub> = 4.5 V; V <sub>EE</sub> = -4.5 V	-	37	60	-	75	-	90	ns
		Sn to $V_{os}$ ; $R_L = 1 \text{ k}\Omega$ ; see Fig. 12								
		V <sub>CC</sub> = 4.5 V; V <sub>EE</sub> = 0 V	-	39	75	-	94	-	113	ns
		V <sub>CC</sub> = 4.5 V; V <sub>EE</sub> = -4.5 V	-	30	60	-	75	-	90	ns
t <sub>off</sub>	turn-OFF	E1 to V <sub>os</sub> ; R <sub>L</sub> = 1 kΩ; see Fig. 12								
	time	V <sub>CC</sub> = 4.5 V; V <sub>EE</sub> = 0 V	-	27	55	-	69	-	83	ns
	_	V <sub>CC</sub> = 4.5 V; V <sub>EE</sub> = -4.5 V	-	20	40	-	50	-	60	ns
		E2 to $V_{os}$ ; $R_L$ = 1 k $\Omega$ ; see Fig. 12								
		V <sub>CC</sub> = 4.5 V; V <sub>EE</sub> = 0 V	-	32	60	-	75	-	90	ns
		V <sub>CC</sub> = 4.5 V; V <sub>EE</sub> = -4.5 V	-	26	50	-	63	-	75	ns
		$\overline{\text{LE}}$ to V <sub>os</sub> ; R <sub>L</sub> = 1 kΩ; see <u>Fig. 12</u>								
		V <sub>CC</sub> = 4.5 V; V <sub>EE</sub> = 0 V	-	33	60	-	75	-	90	ns
		V <sub>CC</sub> = 4.5 V; V <sub>EE</sub> = -4.5 V	-	30	55	-	69	-	83	ns
		Sn to $V_{os}$ ; $R_L$ = 1 k $\Omega$ ; see <u>Fig. 12</u>								
		V <sub>CC</sub> = 4.5 V; V <sub>EE</sub> = 0 V	-	33	65	-	81	-	98	ns
		V <sub>CC</sub> = 4.5 V; V <sub>EE</sub> = -4.5 V	-	29	55	-	69	-	83	ns
t <sub>su</sub>	set-up time	Sn to $\overline{\text{LE}}$ ; R <sub>L</sub> = 1 k $\Omega$ ; see <u>Fig. 13</u>								
		V <sub>CC</sub> = 4.5 V; V <sub>EE</sub> = 0 V	12	6	-	-	15	-	18	ns
		V <sub>CC</sub> = 4.5 V; V <sub>EE</sub> = -4.5 V	14	7	-	-	18	-	21	ns
t <sub>hold</sub>	hold time	Sn to $\overline{\text{LE}}$ ; $R_{\text{L}}$ = 1 k $\Omega$ ; see <u>Fig. 13</u>								
		V <sub>CC</sub> = 4.5 V; V <sub>EE</sub> = 0 V	5	-1	-	-	5	-	5	ns
		$V_{CC}$ = 4.5 V; $V_{EE}$ = -4.5 V	5	-2	-	-	5	-	5	ns
t <sub>WH(min)</sub>	minimum	LE; R <sub>L</sub> = 1 kΩ; see <u>Fig. 13</u>								
	pulse width HIGH	V <sub>CC</sub> = 4.5 V; V <sub>EE</sub> = 0 V	25	13	-	-	31	-	38	ns
		V <sub>CC</sub> = 4.5 V; V <sub>EE</sub> = -4.5 V	25	13	-	-	31	-	38	ns
C <sub>pd</sub>	power dissipation capacitance	per switch; [2] $V_I = GND$ to $V_{CC}$ - 1.5 V	-	25	-	-	-	-	-	pF

Symbol	Parameter	Conditions	25 °C		25 °C -40 °C to +85 °C ·		-40 °C to +125 °C		Unit	
			Min	Тур	Max	Min	Max	Min	Max	
C <sub>sw</sub> switch		maximum								
	capacitance	independent (Yn)	-	5	-	-	-	-	-	pF
		common (Z)	-	25	-	-	-	-	-	pF

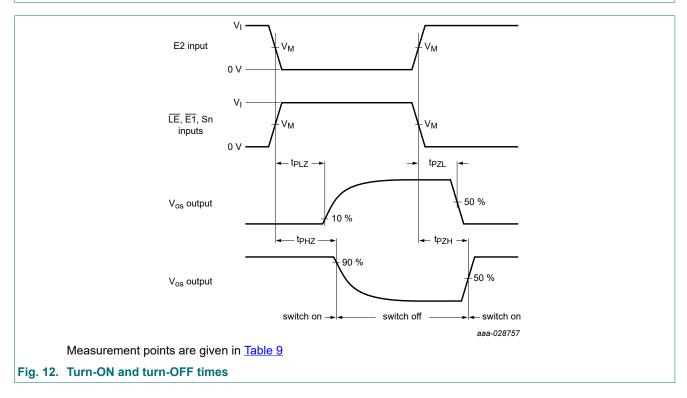
 $P_{D} = C_{PD} \times V_{CC}^{2} \times f_{i} \times N + \Sigma \{(C_{L} + C_{sw}) \times V_{CC}^{2} \times f_{o}\} \text{ where:}$  $f_i$  = input frequency in MHz; fo = output frequency in MHz; N = number of inputs switching;  $\Sigma$ {(C<sub>L</sub> + C<sub>sw</sub>) × V<sub>CC</sub><sup>2</sup> × f<sub>o</sub>} = sum of outputs;  $C_{L}$  = output load capacitance in pF; C<sub>sw</sub> = switch capacitance in pF;

 $V_{CC}$  = supply voltage in V.

# 11.1. Waveforms and test circuit



## Fig. 11. Input (V<sub>is</sub>) to output (V<sub>os</sub>) propagation delays



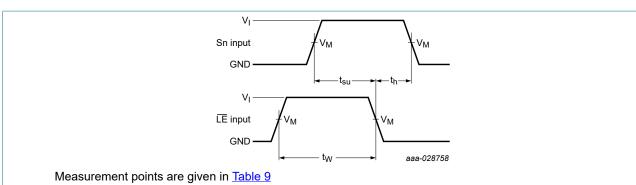


Fig. 13. Set-up and hold times from Sn inputs to LE input, and minimum pulse width of LE.

#### Table 9. Measurement points

Туре	Input		Output
	VI	V <sub>M</sub>	V <sub>M</sub>
74HC4351-Q100	GND to V <sub>CC</sub>	0.5 × V <sub>CC</sub>	$0.5 \times V_{CC}$
74HCT4351-Q100	GND to 3 V	1.3 V	1.3 V

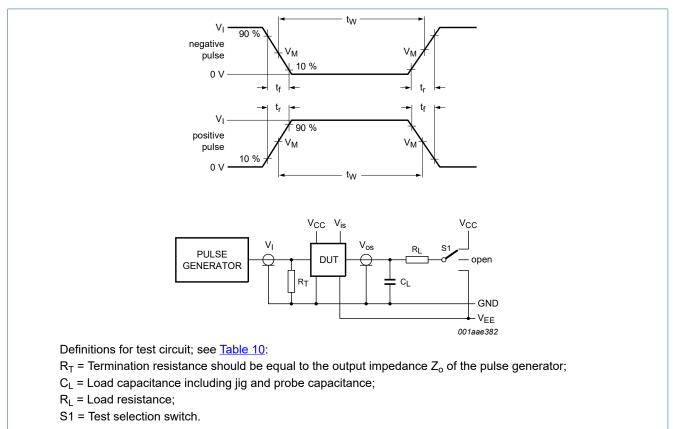


Fig. 14. Test circuit for measuring switching times

## Table 10. Test data

Test	Input				Load	Load		
	VI	V <sub>is</sub>	t <sub>r</sub> , t <sub>f</sub>		CL	RL		
			at f <sub>max</sub>	other [1]				
t <sub>PZH</sub> , t <sub>PHZ</sub>	[2]	V <sub>CC</sub>	< 2 ns	6 ns	50 pF	1 kΩ	V <sub>EE</sub>	
t <sub>PZL</sub> , t <sub>PLZ</sub>	[2]	V <sub>EE</sub>	< 2 ns	6 ns	50 pF	1 kΩ	V <sub>CC</sub>	
Other	[2]	pulse	< 2 ns	6 ns	50 pF	1 kΩ	open	

[1]  $t_r = t_f = 6$  ns; when measuring  $f_{max}$ , there is no constraint to  $t_r$  and  $t_f$  with 50 % duty factor. [2]  $V_1$  values:

For 74HC4351-Q100: V<sub>I</sub> = V<sub>CC</sub> For 74HCT4351-Q100: VI = 3 V

74HC\_HCT4351\_Q100

# **11.2.** Additional dynamic characteristics

## Table 11. Additional dynamic characteristics

Recommended conditions and typical values; GND = 0 V;  $T_{amb} = 25 °C$ ;  $C_L = 50 pF$  unless stated otherwise.  $V_{is}$  is the input voltage at pins Yn or Z, whichever is assigned as an input.

 $V_{os}$  is the output voltage at pins Yn or Z, whichever is assigned as an output.

Symbol	Parameter	Conditions		Min	Тур	Max	Unit
d <sub>sin</sub>	sine-wave distortion	$f_i$ = 1 kHz; R <sub>L</sub> = 10 kΩ; see <u>Fig. 15</u>					
	V <sub>is</sub> = 4.0 V (p-p); V <sub>CC</sub> = 2.25 V; V <sub>EE</sub> = -2.25 V		-	0.04	-	%	
		V <sub>is</sub> = 8.0 V (p-p); V <sub>CC</sub> = 4.5 V; V <sub>EE</sub> = -4.5 V	-	0.02	-	%	
		$f_i = 10 \text{ kHz}; R_L = 10 \text{ k}\Omega; \text{ see } \underline{\text{Fig. 15}}$					
		$V_{is}$ = 4.0 V (p-p); $V_{CC}$ = 2.25 V; $V_{EE}$ = -2.25 V		-	0.12	-	%
		V <sub>is</sub> = 8.0 V (p-p); V <sub>CC</sub> = 4.5 V; V <sub>EE</sub> = -4.5 V		-	0.06	-	%
$\alpha_{iso}$ isolation (OFF-state)	R <sub>L</sub> = 600 Ω; f <sub>i</sub> = 1 MHz; see <u>Fig. 16</u>						
		V <sub>CC</sub> = 2.25 V; V <sub>EE</sub> = -2.25 V	[1]	-	-50	-	dB
		V <sub>CC</sub> = 4.5 V; V <sub>EE</sub> = -4.5 V	[1]	-	-50	-	dB
V <sub>ct</sub> crosstalk voltage	between control and any switch (peak-to-peak value); $R_L = 600 \Omega$ ; $f_i = 1 MHz$ ; $\overline{E1}$ , E2 or Sn square wave between V <sub>CC</sub> and GND; $t_r = t_f = 6 ns$ ; see Fig. 17						
		V <sub>CC</sub> = 4.5 V; V <sub>EE</sub> = 0 V		-	120	-	mV
		V <sub>CC</sub> = 4.5 V; V <sub>EE</sub> = -4.5 V		-	220	-	mV
( /	-3 dB frequency response	$R_L = 50 \Omega; C_L = 10 pF see Fig. 18$					
		V <sub>CC</sub> = 2.25 V; V <sub>EE</sub> = -2.25 V	[2]	-	160	-	MHz
		V <sub>CC</sub> = 4.5 V; V <sub>EE</sub> = -4.5 V	[2]	-	170	-	MHz

[1] Adjust input voltage  $V_{is}$  to 0 dBm level (0 dBm = 1 mW into 600  $\Omega$ ).

[2] Adjust input voltage  $V_{is}$  to 0 dBm level at  $V_{os}$  for 1 MHz (0 dBm = 1 mW into 50  $\Omega$ ).

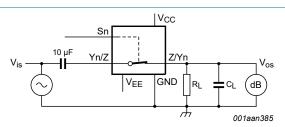


Fig. 15. Test circuit for measuring sine-wave distortion

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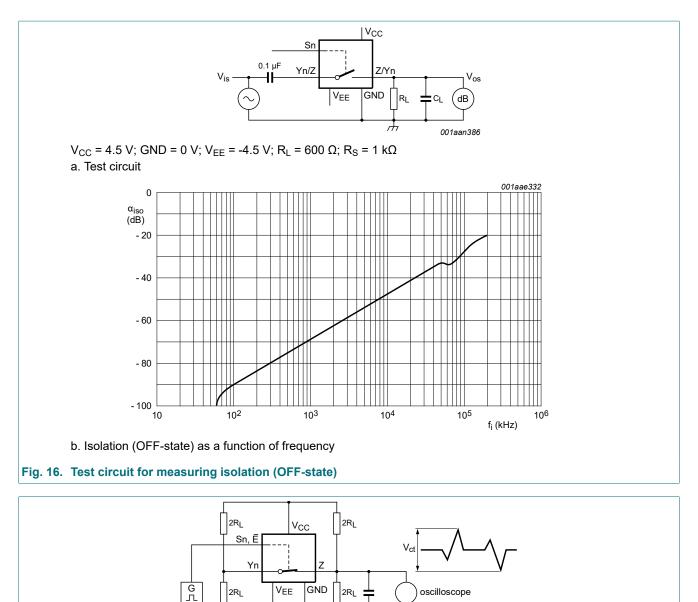
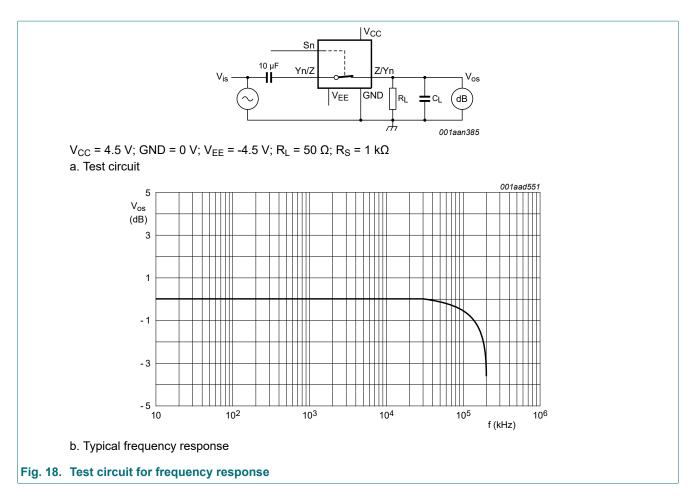
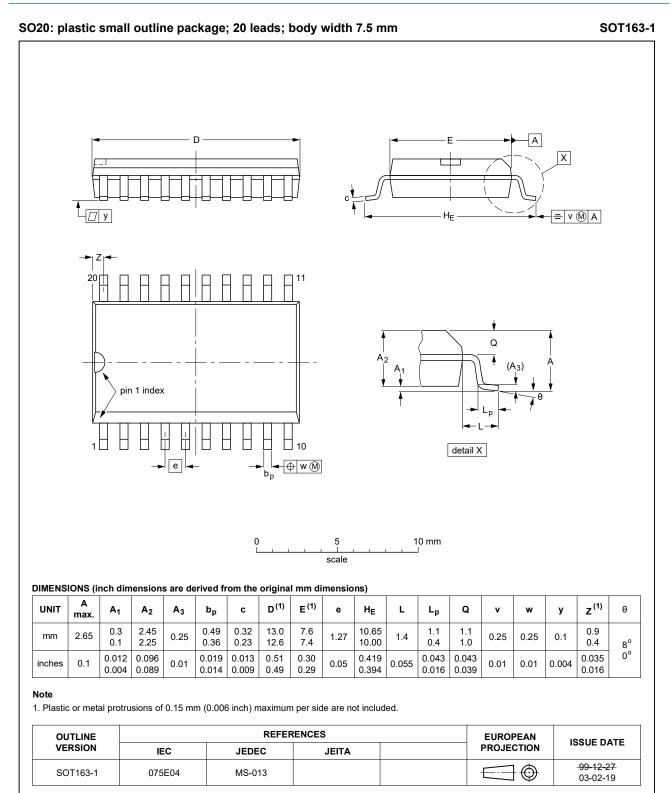


Fig. 17. Test circuit for measuring crosstalk between control input and any switch



# 12. Package outline



#### Fig. 19. Package outline SOT163-1 (SO20)

74HC\_HCT4351\_Q100

# 13. Abbreviations

Table 12. Abbreviations				
Acronym	Description			
CDM	Charged Device Model			
DUT	Device Under Test			
ESD	ElectroStatic Discharge			
HBM	Human Body Model			
MM	Machine Model			

# 14. Revision history

Table 13. Revision history					
Document ID	Release date	Data sheet status	Change notice	Supersedes	
74HC_HCT4351_Q100 v.1	20231102	Product data sheet	-	-	

# 15. Legal information

#### Data sheet status

Document status [1][2]	Product status [3]	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
Preliminary [short] data sheet	Qualification	This document contains data from the preliminary specification.
Product [short] data sheet	Production	This document contains the product specification.

 Please consult the most recently issued document before initiating or completing a design.

[2] The term 'short data sheet' is explained in section "Definitions".

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# Contents

1. General description	1
2. Features and benefits	1
3. Applications	1
4. Ordering information	1
5. Functional diagram	2
6. Pinning information	3
6.1. Pinning	3
6.2. Pin description	3
7. Functional description	4
8. Limiting values	4
9. Recommended operating conditions	5
10. Static characteristics	6
11. Dynamic characteristics	9
11.1. Waveforms and test circuit	12
11.2. Additional dynamic characteristics	15
12. Package outline	18
13. Abbreviations	19
14. Revision history	19
15. Legal information	20

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74HC\_HCT4351\_Q100

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